

<b>Notice of References Cited</b>	Application/Control No. 10/801,872	Applicant(s)/Patent Under Reexamination MEEK ET AL.	
	Examiner Benny Q. Tieu	Art Unit 2642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,537,464	07-1996	Lewis et al.	379/114.25
	B	US-6,148,070	11-2000	Meek et al.	379/210.02
	C	US-6,516,057	02-2003	Meek et al.	379/196
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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